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Contact us

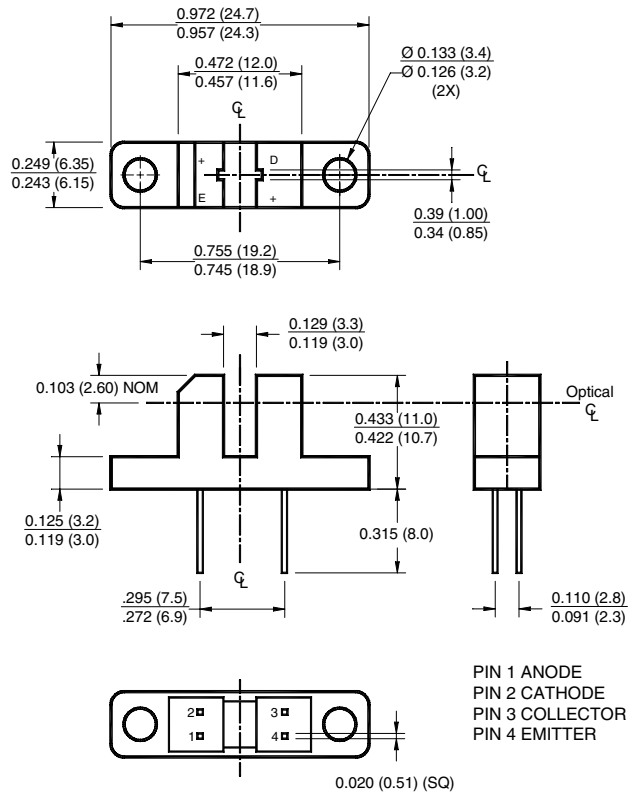
Tel: +86-755-8981 8866 Fax: +86-755-8427 6832
Email & Skype: info@chipsmall.com Web: www.chipsmall.com
Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China

FAIRCHILD
SEMICONDUCTOR®

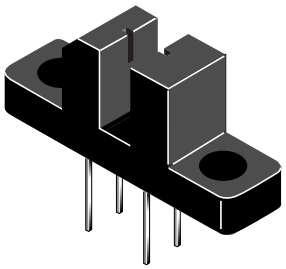
PHOTOTRANSISTOR OPTICAL INTERRUPTER SWITCH

CNY28

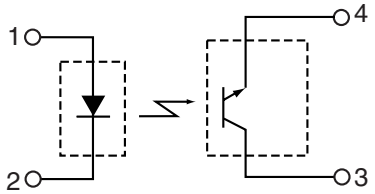
PACKAGE DIMENSIONS



NOTES:
1. Dimensions for all drawings are in inches (mm).
2. Tolerance of ± .010 (.25) on all non-nominal dimensions unless otherwise specified.



SCHEMATIC



DESCRIPTION

The CNY28 is a gallium arsenide infrared emitting diode coupled with a silicon phototransistor in a plastic housing. The gap in the housing provides a means of interrupting the signal with tape, cards, shaft encoders or other opaque material, switching the output from an “ON” to an “OFF” state.

FEATURES

- Opaque housing
- Low cost
- 0.035” apertures
- European “Pro Electron” registered

PHOTOTRANSISTOR OPTICAL INTERRUPTER SWITCH

CNY28

ABSOLUTE MAXIMUM RATINGS (T_A = 25°C unless otherwise specified)

Parameter	Symbol	Rating	Units
Operating Temperature	T_{OPR}	-55 to +85	°C
Storage Temperature	T_{STG}	- 55 to +85	°C
Soldering Temperature (Iron)(2,3,4)	T_{SOL-I}	240 for 5 sec	°C
Soldering Temperature (Flow)(2,3)	T_{SOL-F}	260 for 10 sec	°C
INPUT (EMITTER)			
Continuous Forward Current	I_F	50	mA
Reverse Voltage	V_R	6	V
Power Dissipation(1)	P_D	100	mW
OUTPUT (SENSOR)			
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter- Collector Voltage	V_{ECO}	4.5	V
Collector Current	I_C	20	mA
Power Dissipation(1)	P_D	150	mW

NOTES:

1. Derate power dissipation linearly 1.67 mW/°C above 25°C.
2. RMA flux is recommended.
3. Methanol or isopropyl alcohols are recommended as cleaning agents.
4. Soldering iron 1/16" (1.6mm) from housing.

ELECTRICAL / OPTICAL CHARACTERISTICS (T_A = 25°C)

PARAMETER	TEST CONDITIONS	SYMBOL	MIN	TYP	MAX	UNITS
INPUT (EMITTER)						
Forward Voltage	I_F = 10 mA	V_F	—	—	1.7	V
Reverse Leakage Current	V_R = 2 V	I_R	—	—	10	µA
OUTPUT (SENSOR)						
Emitter-Collector Breakdown	I_E = 100 µA, E_e = 0	BV_{ECO}	5.0	—	—	V
Collector-Emitter Breakdown	I_C = 10 mA, E_e = 0	BV_{CEO}	30	—	—	V
Collector-Emitter Leakage	V_{CE} = 10 V, E_e = 0	I_{CEO}	—	—	100	nA
COUPLED						
Collector Current	I_F = 20 mA, V_{CE} = 10 V	$I_{C(ON)}$	0.20	—	—	mA
Collector Emitter Saturation Voltage	I_F = 20 mA, I_C = 25 µA	$V_{CE\ (SAT)}$	—	—	0.40	V
Turn-On Time	I_F = 30 mA, V_{CC} = 5 V, R_L = 2.5 kΩ	t_{on}	—	5	—	µs
Turn-Off Time	I_F = 30 mA, V_{CC} = 5 V, R_L = 2.5 kΩ	t_{off}	—	5	—	µs

TYPICAL PERFORMANCE CURVES

Fig. 1 Output Current vs. Input Current

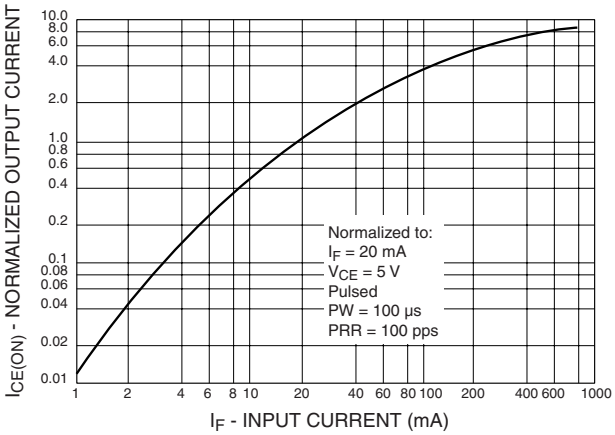


Fig. 2 Output Current vs. Temperature

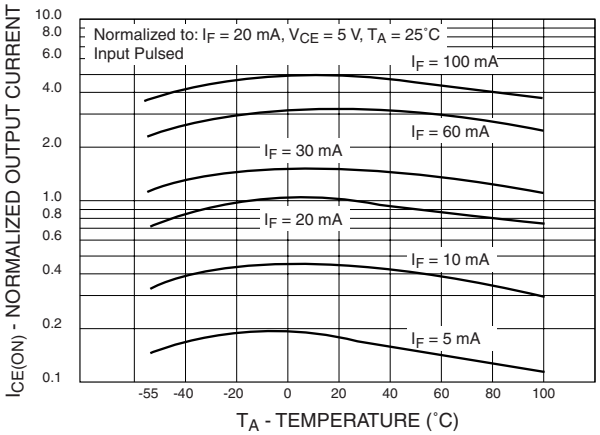


Fig. 3 Saturation Voltage vs. Ambient Temperature

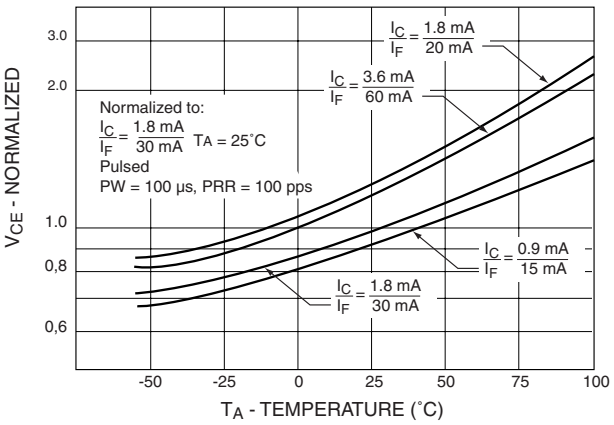


Fig. 4 Normalized Dark Current vs. Ambient Temperature (Detector)

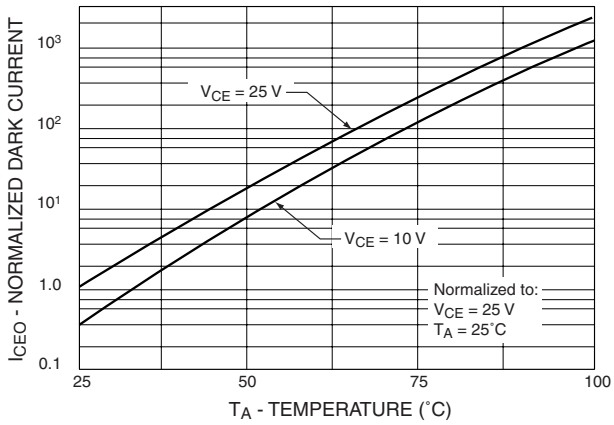
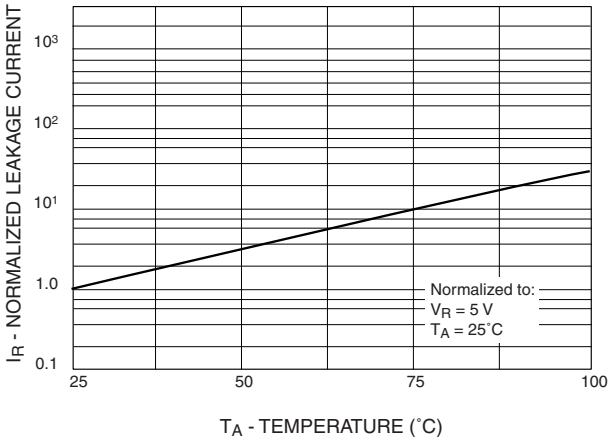


Fig. 5 Normalized Leakage Current vs. Ambient Temperature (Emitter)



TYPICAL PERFORMANCE CURVES

Fig. 6 Switching Time vs. Load Resistance

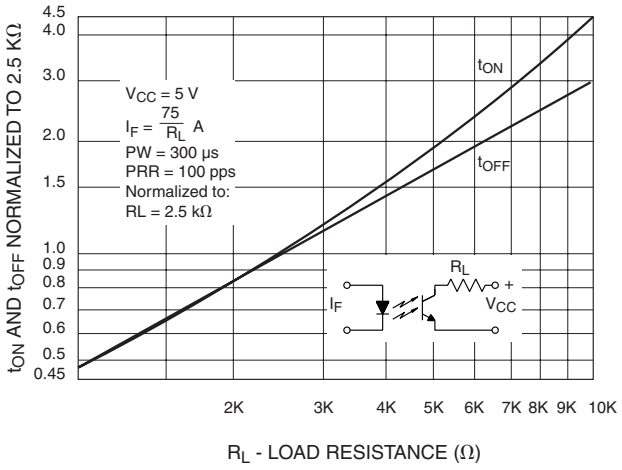
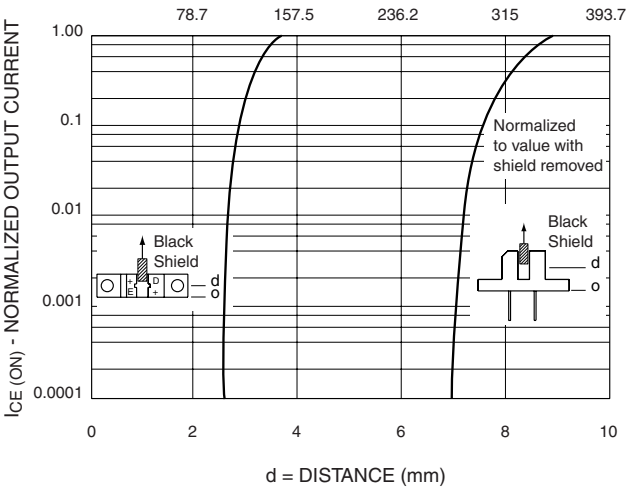


Fig. 7 Output Current vs. Distance



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